

STS30N3LLH6

N-channel 30 V, 0.0016 Ω, 30 A, SO-8 STripFET™ VI DeepGATE™ Power MOSFET

Preliminary Data

Features

Туре	V _{DSS}	R _{DS(on)} max	I _D
STS30N3LLH6	30 V	0.002Ω	30 A

- R_{DS(on)} * Q_g industry benchmark
- Extremely low on-resistance R_{DS(on)}
- High avalanche ruggedness
- Low gate drive power losses
- Very low switching gate charge

Application

■ Switching applications



This product utilizes the 6th generation of design rules of ST's proprietary STripFETTM technology, with a new gate structure. The resulting Power MOSFET exhibits the lowest $R_{DS(on)}$ in a standard package, that makes it suitable for the most demanding DC-DC converter applications, where high power density has to be achieved.

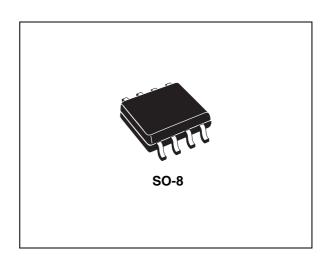


Figure 1. Internal schematic diagram

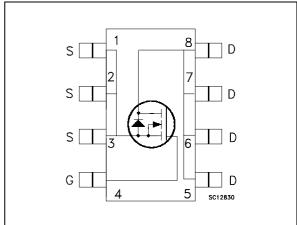


Table 1. Device summary

Order code	Marking	Packag	Packaging
STS30N3LLH6	30G3L	SO-8	Tape and reel

Contents STS30N3LLH6

Contents

1	Electrical ratings	3
2	Electrical characteristics	4
3	Test circuit	6
4	Package mechanical data	8
5	Revision history	10

STS30N3LLH6 Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit		
V _{DS}	Drain-source voltage (V _{GS} = 0)	30	V		
V _{GS} ⁽¹⁾	Gate-source voltage	± 20	V		
I _D	Drain current (continuous) at T _C = 25 °C 30				
I _D	Drain current (continuous) at T _C =100 °C	18.75	Α		
I _{DM} ⁽²⁾	Drain current (pulsed) 120				
P _{TOT}	Total dissipation at T _C = 25 °C	2.7	W		
T _J T _{stg}	Operating junction temperature Storage temperature	-55 to 150			

^{1.} Continuous mode

Table 3. Thermal resistance

Symbol	Parameter	Value	Unit
R _{thj-amb} (1)	Thermal resistance junction-ambient	47	°C/W

^{1.} When mounted on FR-4 board of 1inch², 2oz Cu, t < 10 sec

Table 4. Avalanche data

Symbol	Parameter Value				
I _{AV}	Not-repetitive avalanche current	TBD	Α		
E _{AS}	Single pulse avalanche energy (starting Tj=25 $^{\circ}$ C, $I_D=I_{AV}$)	TBD			

^{2.} Pulse width limited by safe operating area

Electrical characteristics STS30N3LLH6

2 Electrical characteristics

 $(T_{CASE} = 25 \, ^{\circ}C \text{ unless otherwise specified})$

Table 5. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0$	30			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = Max rating, V_{DS} = Max rating @125 °C			1 10	μ Α μ Α
I _{GSS}	Gate body leakage current (V _{DS} = 0)	V _{GS} = ±20 V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1			V
R _{DS(on)}	Static drain-source on resistance	V_{GS} = 10 V, I_{D} = 15 A V_{GS} = 4.5 V, I_{D} = 15 A		0.0016 0.003	0.002 0.0035	Ω Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} =25 V, f=1 MHz, V _{GS} =0		3700 728 306		pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD} =15 V, I_{D} = 30 A V_{GS} =4.5 V Figure 8		29 TBD TBD	TBD	nC nC nC
R _G	Gate Input Resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20 mV open drain		TBD		Ω

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$t_{d(on)} \ t_{r} \ t_{d(off)} \ t_{f}$	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} =15 V, I_{D} = 15 A, R_{G} =4.7 Ω , V_{GS} =4.5 V Figure 2		TBD TBD TBD TBD		ns ns ns ns

Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I _{SD}	Source-drain current				30	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)				120	Α
V _{SD} ⁽²⁾	Forward on Voltage	I _{SD} =15 A, V _{GS} =0			1.1	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} =15 A, di/dt = 100 A/ μ s, V_{DD} =20 V, Tj=150 °C Figure 4		TBD TBD TBD		ns nC A

^{1.} Pulse width limited by safe operating area

^{2.} Pulsed: pulse duration=300 μs , duty cycle 1.5%

Test circuit STS30N3LLH6

3 Test circuit

Figure 2. Switching times test circuit for resistive load

Figure 3. Gate charge test circuit

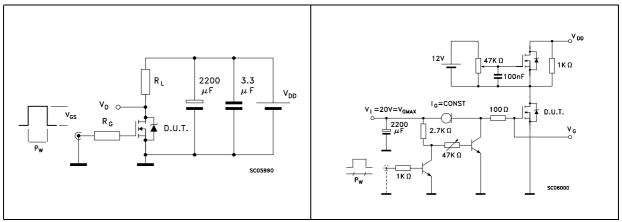


Figure 4. Test circuit for inductive load switching and diode recovery times

Figure 5. Unclamped inductive load test circuit

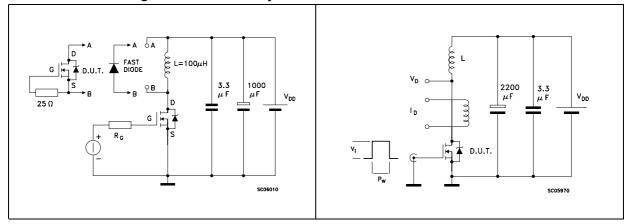
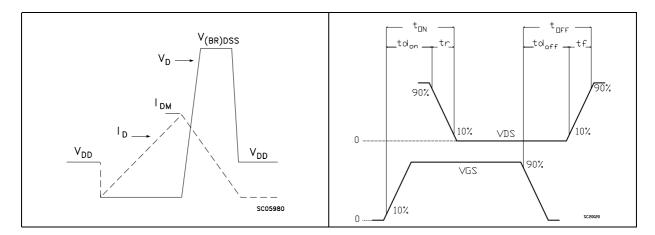


Figure 6. Unclamped inductive waveform

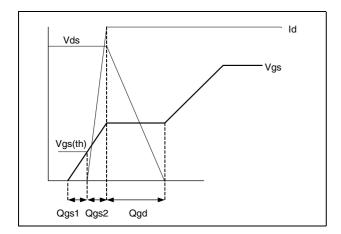
Figure 7. Switching time waveform



577

STS30N3LLH6 Test circuit

Figure 8. Gate charge waveform

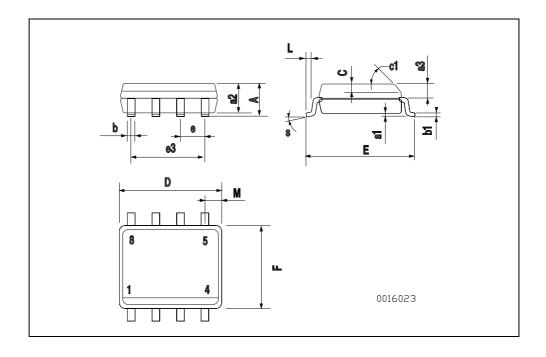


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

SO-8 MECHANICAL DATA

DIM		mm.			inch	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
a3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
С	0.25		0.5	0.010		0.019
c1			45 ((typ.)		
D	4.8		5.0	0.188		0.196
E	5.8		6.2	0.228		0.244
е		1.27			0.050	
e3		3.81			0.150	
F	3.8		4.0	0.14		0.157
L	0.4		1.27	0.015		0.050
М			0.6			0.023
S		•	8 (n	nax.)	•	•



577

Revision history STS30N3LLH6

5 Revision history

Table 9. Document revision history

Date	Revision	Changes
27-Jan-2009	1	First release

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